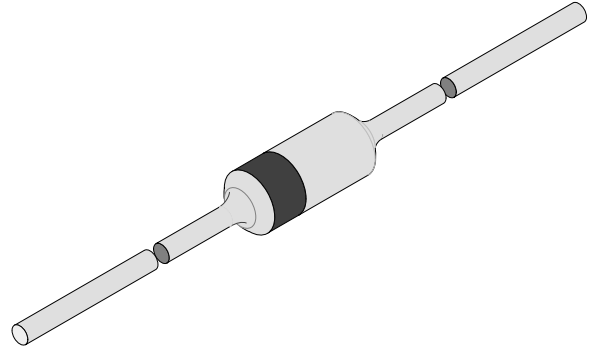


Silicon Epitaxial Planar Diodes

Applications

General purposes



94 9367

Absolute Maximum Ratings

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Value	Unit
Peak reverse voltage		BAV17	V_{RRM}	25	V
		BAV18	V_{RRM}	60	V
		BAV19	V_{RRM}	120	V
		BAV20	V_{RRM}	200	V
		BAV21	V_{RRM}	250	V
Reverse voltage		BAV17	V_R	20	V
		BAV18	V_R	50	V
		BAV19	V_R	100	V
		BAV20	V_R	150	V
		BAV21	V_R	200	V
Forward current			I_F	250	mA
Peak forward surge current	$t_p=1\text{s}, T_j=25^\circ\text{C}$		I_{FSM}	1	A
Forward peak current	$f=50\text{Hz}$		I_{FM}	625	mA
Junction temperature			T_j	175	$^\circ\text{C}$
Storage temperature range			T_{stg}	-65...+175	$^\circ\text{C}$

Maximum Thermal Resistance

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Junction ambient	$l=4\text{mm}, T_L=\text{constant}$	R_{thJA}	350	K/W

Characteristics

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Forward voltage	$I_F=100\text{mA}$		V_F			1	V
Reverse current	$V_R=20\text{V}$	BAV17	I_R			100	nA
	$V_R=50\text{V}$	BAV18	I_R			100	nA
	$V_R=100\text{V}$	BAV19	I_R			100	nA
	$V_R=150\text{V}$	BAV20	I_R			100	nA
	$V_R=200\text{V}$	BAV21	I_R			100	nA
Reverse current	$T_j=100^\circ\text{C}, V_R=20\text{V}$	BAV17	I_R			15	μA
	$T_j=100^\circ\text{C}, V_R=50\text{V}$	BAV18	I_R			15	μA
	$T_j=100^\circ\text{C}, V_R=100\text{V}$	BAV19	I_R			15	μA
	$T_j=100^\circ\text{C}, V_R=150\text{V}$	BAV20	I_R			15	μA
	$T_j=100^\circ\text{C}, V_R=200\text{V}$	BAV21	I_R			15	μA
Breakdown voltage	$I_R=100\mu\text{A}, t_p/T=0.01,$ $t_p=0.3\text{ms}$	BAV17	$V_{(BR)}$	25			V
		BAV18	$V_{(BR)}$	60			V
		BAV19	$V_{(BR)}$	120			V
		BAV20	$V_{(BR)}$	200			V
		BAV21	$V_{(BR)}$	250			V
Diode capacitance	$V_R=0, f=1\text{MHz}$		C_D		1.5		pF
Differential forward resistance	$I_F=10\text{mA}$		r_f		5		Ω
Reverse recovery time	$I_F=I_R=30\text{mA}, i_R=3\text{mA},$ $R_L=100\Omega$		t_{rr}			50	ns

Typical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

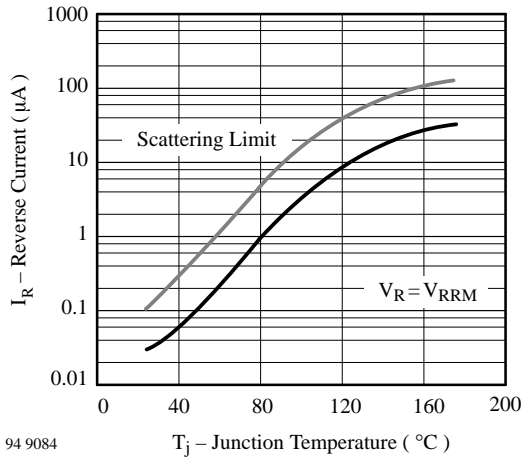


Figure 1. Reverse Current vs. Junction Temperature

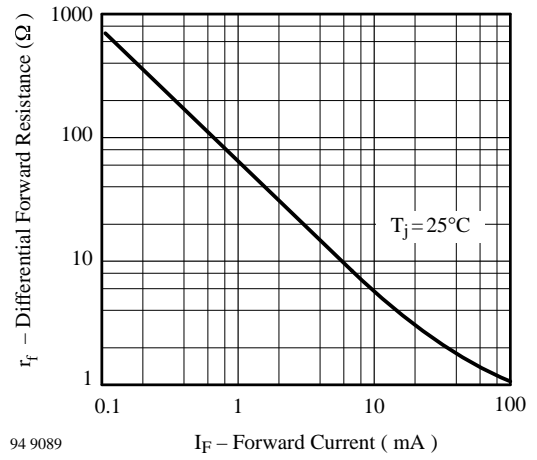


Figure 3. Differential Forward Resistance vs. Forward Current

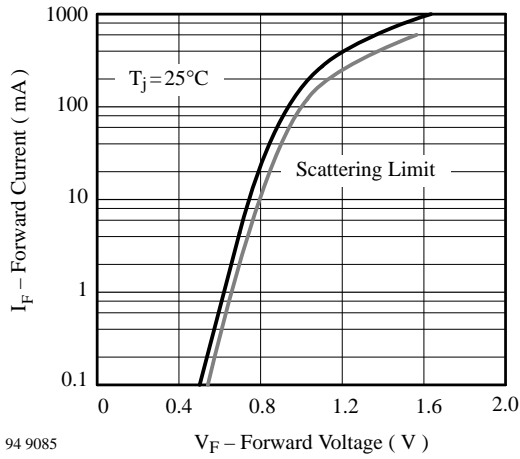


Figure 2. Forward Current vs. Forward Voltage

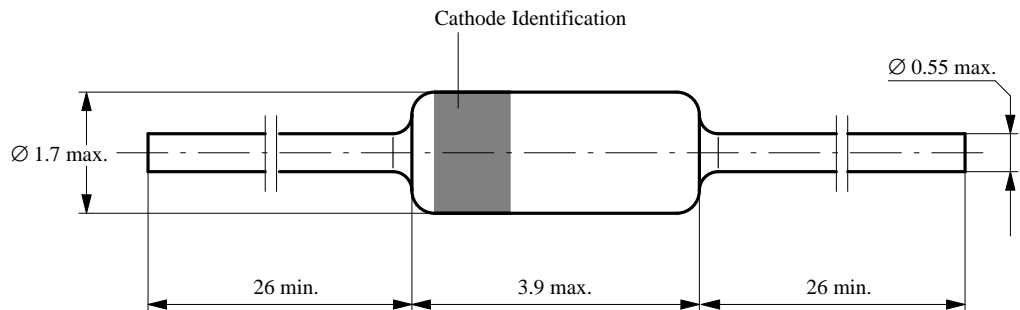
Dimensions in mm



technical drawings
according to DIN
specifications

94 9366

Standard Glass Case
54 A 2 DIN 41880
JEDEC DO 35
Weight max. 0.3 g



Ozone Depleting Substances Policy Statement

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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